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## 8 BIT ADDRESSABLE LATCH

- SERIAL DATA INPUT - ACTIVE PARALLEL OUTPUT
- STORAGE REGISTER CAPABILITY MASTER CLEAR
- CAN FUNCTION AS DEMULTIPLEXER
- QUIESCENT CURRENT SPECIFIED UP TO 20V
- STANDARDIZED SYMMETRICAL OUTPUT CHARACTERISTICS
- INPUT LEAKAGE CURRENT $I_{I}=100 \mathrm{nA}(M A X) A T V_{D D}=18 \mathrm{~V}_{\mathrm{A}}=25^{\circ} \mathrm{C}$
- $100 \%$ TESTED FOR QUIESCENT CURRENT
- MEETS ALL REQUIREMENTS OF JEDEC JESD13B "STANDARD SPECIFICATIONS FOR DESCRIPTION OF B SERIES CMOS DEVICES"


## DESCRIPTION

HCF4099B is a monolithic integrated circuit fabricated in Metal Oxide Semiconductor technology available in DIP and SOP packages. HCF4099B, an 8-bit addressable latch, is a serial-input, parallel output storage register that can perform a variety of functions. Data is input to a particular bit in the latch when that bit is addressed (by means of input A0, A1, A2) and when WRITE DISABLE is at a low level. When


## ORDER CODES

| PACKAGE | TUBE | T \& R |
| :---: | :---: | :---: |
| DIP | HCF4099BEY |  |
| SOP | HCF4099BM1 | HCF4099M013TR |

WRITE DISABLE is high, data entry is inhibited; however, all 8 outputs can be continuously read independent of WRITE DISABLE and address inputs. A master RESET input is available, which resets all bits to a logic "0" level when RESET and WRITE DISABLE are at a high level. When RESET is at a high level, and WRITE DISABLE is at a low level, the latch acts as a 1-of-8 demultiplexer ; the bit that is addressed has an active output which follows the data input, while all unaddressed bits are held to a logic " 0 " level.

## PIN CONNECTION



HCF4099B

IINPUT EQUIVALENT CIRCUIT


PIN DESCRIPTION

| PIN No | SYMBOL | NAME AND FUNCTION |
| :---: | :---: | :--- |
| $5,6,7$ | A0 to A2 | Address Inputs |
| $9,10,11,12$, <br> $13,14,15,1$ | Q0 to Q7 | Latch Outputs |
| 3 | DATA | Data Inputs |
| 2 | RESET | Reset Input |
| 4 | WRITE <br> DISABLE | Write Disable Input |
| 8 | V $_{\text {SS }}$ | Negative Supply Voltage |
| 16 | V $_{\text {DD }}$ | Positive Supply Voltage |

## FUNCTIONAL DIAGRAM

$\pm 2$

TRUTH TABLE

| SELECT INPUTS |  |  | LATCH ADDRESSED |
| :---: | :---: | :---: | :---: |
| C | B | A |  |
| L | L | L | Q0 |
| L | L | H | Q1 |
| L | H | L | Q2 |
| L | H | H | Q3 |
| H | L | L | Q4 |
| H | L | H | Q5 |
| H | H | L | Q6 |
| H | H | H | Q7 |


| INPUTS |  | OUTPUTS OF <br> ADDRESSED <br> LATCH | EACH OTHER <br> OUTPUT | FUNCTION |
| :---: | :---: | :---: | :---: | :---: |
| WRITE DISABLE | RESET | D | Qio | ADDRESSABLE LATCH |
| L | L | Qio | Qio | MEMORY |
| L | H | L | L | DEMULTIPLEXER |
| H | L | L | L | CLEAR ALL BITS TO "0" |
| H | H |  |  |  |

D: The level at the data input ; $Q_{i 0}$ The level before the indicated steady state input conditions were established, (i=0, 1, ...7)

## LOGIC DIAGRAM



TIMING CHART


## ABSOLUTE MAXIMUM RATINGS

| Symbol | Parameter | Value | Unit |
| :---: | :--- | :---: | :---: |
| $\mathrm{V}_{\mathrm{DD}}$ | Supply Voltage | -0.5 to +22 | V |
| $\mathrm{~V}_{\mathrm{I}}$ | DC Input Voltage | -0.5 to $\mathrm{V}_{\mathrm{DD}}+0.5$ | V |
| $\mathrm{I}_{\mathrm{I}}$ | DC Input Current | $\pm 10$ | mA |
| $\mathrm{P}_{\mathrm{D}}$ | Power Dissipation per Package | 200 | mW |
|  | Power Dissipation per Output Transistor | 100 | mW |
| $\mathrm{~T}_{\mathrm{op}}$ | Operating Temperature | -55 to +125 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\text {stg }}$ | Storage Temperature | -65 to +150 | ${ }^{\circ} \mathrm{C}$ |

Absolute Maximum Ratings are those values beyond which damage to the device may occur. Functional operation under these conditions is not implied.
All voltage values are referred to $\mathrm{V}_{\mathrm{SS}}$ pin voltage.

## RECOMMENDED OPERATING CONDITIONS

| Symbol | Parameter | Value | Unit |
| :---: | :--- | :---: | :---: |
| $\mathrm{V}_{\mathrm{DD}}$ | Supply Voltage | 3 to 20 | V |
| $\mathrm{~V}_{\mathrm{I}}$ | Input Voltage | 0 to $\mathrm{V}_{\mathrm{DD}}$ | V |
| $\mathrm{T}_{\mathrm{op}}$ | Operating Temperature | -55 to 125 | ${ }^{\circ} \mathrm{C}$ |

DC SPECIFICATIONS

| Symbol | Parameter | Test Conditions |  |  |  | Value |  |  |  |  |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | $\begin{gathered} V_{1} \\ (V) \end{gathered}$ | $\begin{aligned} & \mathrm{V}_{\mathrm{O}} \\ & \text { (V) } \end{aligned}$ | $\begin{aligned} & \left\lvert\, \begin{array}{l} \left\|I_{0}\right\| \\ (\mu \mathrm{A}) \end{array}\right. \end{aligned}$ | $\begin{aligned} & V_{D D} \\ & (V) \end{aligned}$ | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ |  |  | -40 to $85^{\circ} \mathrm{C}$ |  | -55 to $125^{\circ} \mathrm{C}$ |  |  |
|  |  |  |  |  |  | Min. | Typ. | Max. | Min. | Max. | Min. | Max. |  |
| $I_{L}$ | Quiescent Current | 0/5 |  |  | 5 |  | 0.04 | 5 |  | 150 |  | 150 | $\mu \mathrm{A}$ |
|  |  | 0/10 |  |  | 10 |  | 0.04 | 10 |  | 300 |  | 300 |  |
|  |  | 0/15 |  |  | 15 |  | 0.04 | 20 |  | 600 |  | 600 |  |
|  |  | 0/20 |  |  | 20 |  | 0.08 | 100 |  | 3000 |  | 3000 |  |
| $\mathrm{V}_{\mathrm{OH}}$ | High Level Output Voltage | 0/5 |  | <1 | 5 | 4.95 |  |  | 4.95 |  | 4.95 |  | V |
|  |  | 0/10 |  | <1 | 10 | 9.95 |  |  | 9.95 |  | 9.95 |  |  |
|  |  | 0/15 |  | <1 | 15 | 14.95 |  |  | 14.95 |  | 14.95 |  |  |
| $\mathrm{V}_{\mathrm{OL}}$ | Low Level Output Voltage | 5/0 |  | $<1$ | 5 |  | 0.05 |  |  | 0.05 |  | 0.05 | V |
|  |  | 10/0 |  | <1 | 10 |  | 0.05 |  |  | 0.05 |  | 0.05 |  |
|  |  | 15/0 |  | <1 | 15 |  | 0.05 |  |  | 0.05 |  | 0.05 |  |
| $\mathrm{V}_{\mathrm{IH}}$ | High Level Input Voltage |  | 0.5/4.5 | <1 | 5 | 3.5 |  |  | 3.5 |  | 3.5 |  | V |
|  |  |  | 1/9 | <1 | 10 | 7 |  |  | 7 |  | 7 |  |  |
|  |  |  | 1.5/18.5 | <1 | 15 | 11 |  |  | 11 |  | 11 |  |  |
| VIL | Low Level Input Voltage |  | 0.5/4.5 | <1 | 5 |  |  | 1.5 |  | 1.5 |  | 1.5 | V |
|  |  |  | 9/1 | <1 | 10 |  |  | 3 |  | 3 |  | 3 |  |
|  |  |  | 1.5/18.5 | <1 | 15 |  |  | 4 |  | 4 |  | 4 |  |
| ${ }^{\mathrm{IOH}}$ | Output Drive Current | 0/5 | 2.5 |  | 5 | -1.36 | -3.2 |  | -1.1 |  | -1.1 |  | mA |
|  |  | 0/5 | 4.6 |  | 5 | -0.44 | -1 |  | -0.36 |  | -0.36 |  |  |
|  |  | 0/10 | 9.5 |  | 10 | -1.1 | -2.6 |  | -0.9 |  | -0.9 |  |  |
|  |  | 0/15 | 13.5 |  | 15 | -3.0 | -6.8 |  | -2.4 |  | -2.4 |  |  |
| $\mathrm{I}_{\text {OL }}$ | Output Sink Current | 0/5 | 0.4 |  | 5 | 0.44 | 1 |  | 0.36 |  | 0.36 |  | mA |
|  |  | 0/10 | 0.5 |  | 10 | 1.1 | 2.6 |  | 0.9 |  | 0.9 |  |  |
|  |  | 0/15 | 1.5 |  | 15 | 3.0 | 6.8 |  | 2.4 |  | 2.4 |  |  |
| I | Input Leakage Current | 0/18 | any input |  | 18 |  | $\pm 10^{-5}$ | $\pm 0.1$ |  | $\pm 1$ |  | $\pm 1$ | $\mu \mathrm{A}$ |
| $\mathrm{C}_{1}$ | Input Capacitance |  | any input |  |  |  | 5 | 7.5 |  |  |  |  | pF |

The Noise Margin for both " 1 " and " 0 " level is: 1 V min. with $\mathrm{V}_{\mathrm{DD}}=5 \mathrm{~V}$, 2 V min. with $\mathrm{V}_{\mathrm{DD}}=10 \mathrm{~V}, 2.5 \mathrm{~V}$ min. with $\mathrm{V}_{\mathrm{DD}}=15 \mathrm{~V}$

## HCF4099B

DYNAMIC ELECTRICAL CHARACTERISTICS $\left(T_{a m b}=25^{\circ} \mathrm{C}, \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}, \mathrm{R}_{\mathrm{L}}=200 \mathrm{~K} \Omega, \mathrm{t}_{\mathrm{r}}=\mathrm{t}_{\mathrm{f}}=20 \mathrm{~ns}\right)$

| Symbol | Parameter | Test Condition |  | Value (*) |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | $\mathrm{V}_{\mathrm{DD}}$ (V) | See Timing Chart | Min. | Typ. | Max. |  |
| $\mathrm{t}_{\text {PLH }} \mathrm{t}_{\text {PHL }}$ | Propagation Delay Time (Data to Output) | 5 | (1) |  | 200 | 400 | ns |
|  |  | 10 |  |  | 75 | 150 |  |
|  |  | 15 |  |  | 50 | 100 |  |
| $\mathrm{t}_{\text {PLH }} \mathrm{t}_{\text {PHL }}$ | Propagation Delay Time (Write Disable to Output) | 5 | (2) |  | 200 | 400 | ns |
|  |  | 10 |  |  | 80 | 160 |  |
|  |  | 15 |  |  | 60 | 120 |  |
| $\mathrm{t}_{\text {PLH }} \mathrm{t}_{\text {PHL }}$ | Propagation Delay Time (Address to Output) | 5 | (9) |  | 225 | 450 | ns |
|  |  | 10 |  |  | 100 | 200 |  |
|  |  | 15 |  |  | 75 | 150 |  |
| $\mathrm{t}_{\text {PHL }}$ | Propagation Delay Time (Reset to Output) | 5 | (3) |  | 175 | 350 | ns |
|  |  | 10 |  |  | 80 | 160 |  |
|  |  | 15 |  |  | 65 | 130 |  |
| ${ }_{\text {t }}{ }^{\text {HLL }}{ }^{\text {TLLH }}$ | Transition Time (any output) | 5 |  |  | 100 | 200 | ns |
|  |  | 10 |  |  | 50 | 100 |  |
|  |  | 15 |  |  | 40 | 80 |  |
| tw | Pulse WIdth (Data) | 5 | (4) | 200 | 100 |  | ns |
|  |  | 10 |  | 100 | 50 |  |  |
|  |  | 15 |  | 80 | 40 |  |  |
| tw | Pulse WIdth (Address) | 5 | (8) | 400 | 200 |  | ns |
|  |  | 10 |  | 200 | 100 |  |  |
|  |  | 15 |  | 125 | 65 |  |  |
| $\mathrm{t}_{\text {w }}$ | Pulse WIdth (Reset) | 5 | (5) | 150 | 75 |  | ns |
|  |  | 10 |  | 75 | 40 |  |  |
|  |  | 15 |  | 50 | 25 |  |  |
| $\mathrm{t}_{\text {setup }}$ | Setup Time (Data to Write Disable) | 5 | (6) | 100 | 50 |  | ns |
|  |  | 10 |  | 50 | 25 |  |  |
|  |  | 15 |  | 35 | 20 |  |  |
| $t_{\text {hold }}$ | Hold Time (Data to Write Disable) | 5 | (7) | 150 | 75 |  | ns |
|  |  | 10 |  | 75 | 40 |  |  |
|  |  | 15 |  | 50 | 25 |  |  |

$\left(^{*}\right)$ Typical temperature coefficient for all $V_{D D}$ value is $0.3 \% /{ }^{\circ} \mathrm{C}$.

TEST CIRCUIT

$\mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}$ or equivalent (includes jig and probe capacitance)
$R_{L}=200 \mathrm{~K} \Omega$
$\mathrm{R}_{\mathrm{T}}=\mathrm{Z}_{\mathrm{OUT}}$ of pulse generator (typically $50 \Omega$ )
WAVEFORM 1 : PROPAGATION DELAY TIME ( $\mathrm{f}=1 \mathrm{MHz} ; 50 \%$ duty cycle)


WAVEFORM 2 : PROPAGATION DELAY TIME ( $\mathrm{f}=1 \mathrm{MHz} ; 50 \%$ duty cycle)


WAVEFORM 3 : MINIMUM PULSE WIDTH, SETUP AND HOLD TIME (f=1MHz; 50\% duty cycle)


WAVEFORM 4 : MINIMUM PULSE WIDTH ( $f=1 \mathrm{MHz} ; 50 \%$ duty cycle)


WAVEFORM 5 : SETUP AND HOLD TIME ( $\mathrm{f}=1 \mathrm{MHz} ; 50 \%$ duty cycle)


WAVEFORM 6 : INPUT WAVEFORMS ( $\mathrm{f}=1 \mathrm{MHz} ; 50 \%$ duty cycle)


TIPICAL APPLICATIONS


## TIPICAL APPLICATIONS



Plastic DIP-16 (0.25) MECHANICAL DATA

| DIM. | mm. |  |  | inch |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | MIN. | TYP | MAX. | MIN. | TYP. | MAX. |
| a1 | 0.51 |  |  | 0.020 |  |  |
| B | 0.77 |  | 1.65 | 0.030 |  | 0.065 |
| b |  | 0.5 |  |  | 0.020 |  |
| b1 |  | 0.25 |  |  | 0.010 |  |
| D |  |  | 20 |  | 0.335 |  |
| E |  | 2.54 |  |  | 0.100 |  |
| e |  | 17.78 |  |  | 0.700 |  |
| e3 |  |  |  |  |  |  |
| F |  |  | 5.1 |  | 0.130 |  |
| I |  | 3.3 |  |  |  | 0.280 |
| L |  |  | 1.27 |  |  | 0.050 |
| Z |  |  |  |  |  |  |



## SO-16 MECHANICAL DATA

| DIM. | mm. |  |  | inch |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | MIN. | TYP | MAX. | MIN. | TYP. | MAX. |
| A |  |  | 1.75 |  |  | 0.068 |
| a1 | 0.1 |  | 0.2 | 0.003 |  | 0.007 |
| a2 |  |  | 1.65 |  |  | 0.064 |
| b | 0.35 |  | 0.46 | 0.013 |  | 0.018 |
| b1 | 0.19 |  | 0.25 | 0.007 |  | 0.010 |
| C |  | 0.5 |  |  | 0.019 |  |
| c1 | $45^{\circ}$ (typ.) |  |  |  |  |  |
| D | 9.8 |  | 10 | 0.385 |  | 0.393 |
| E | 5.8 |  | 6.2 | 0.228 |  | 0.244 |
| e |  | 1.27 |  |  | 0.050 |  |
| e3 |  | 8.89 |  |  | 0.350 |  |
| F | 3.8 |  | 4.0 | 0.149 |  | 0.157 |
| G | 4.6 |  | 5.3 | 0.181 |  | 0.208 |
| L | 0.5 |  | 1.27 | 0.019 |  | 0.050 |
| M |  |  | 0.62 |  |  | 0.024 |
| S | $8^{\circ}$ (max.) |  |  |  |  |  |



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